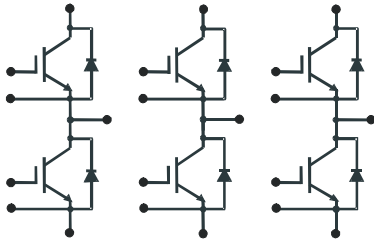


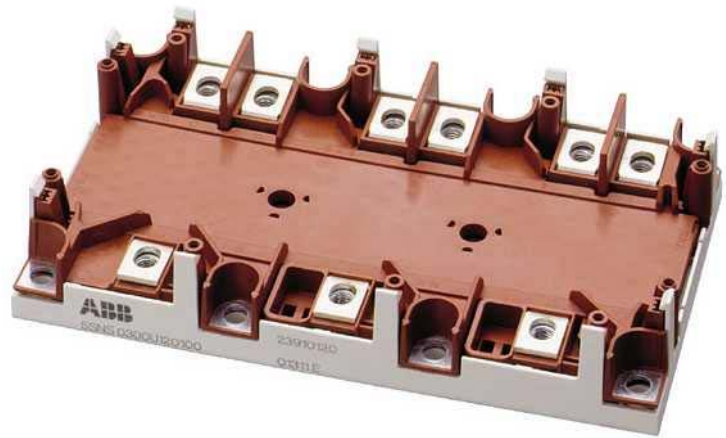
$V_{CE} = 1200\text{ V}$
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 $I_C = 300\text{ A}$

IGBT Module LoPak5 SPT 5SNS 0300U120100



Doc. No. 5SYA1528-02 July 03

- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- Low profile compact baseless package for high power cycling capability
- Snap-on PCB assembly
- Integrated PTC substrate temperature sensor



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0\text{ V}$, $T_{vj} \geq 25\text{ °C}$	1200		V
DC collector current	I_C	$T_h = 60\text{ °C}$		300	A
Peak collector current	I_{CM}	$t_p = 1\text{ ms}$, $T_h = 60\text{ °C}$		600	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_h = 25\text{ °C}$, per switch (IGBT)		960	W
DC forward current	I_F			300	A
Peak forward current	I_{FM}			600	A
Surge current	I_{FSM}	$V_R = 0\text{ V}$, $T_{vj} = 125\text{ °C}$, $t_p = 10\text{ ms}$, half-sinewave		3600	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 900\text{ V}$, $V_{CEM\text{CHIP}} \leq 1200\text{ V}$ $V_{GE} \leq 15\text{ V}$, $T_{vj} \leq 125\text{ °C}$		10	μs
Isolation voltage	V_{isol}	1 min, $f = 50\text{ Hz}$		2500	V
Junction temperature	T_{vj}			150	$^{\circ}\text{C}$
Case operating temperature	$T_{c(op)}$		-40	125	$^{\circ}\text{C}$
Storage temperature	T_{stg}		-40	125	$^{\circ}\text{C}$
Mounting torques	M_1	Base-heatsink, M5 screws	2	3	Nm
	M_2	Main terminals, M6 screws	4	5	

1) Maximum rated values indicate limits beyond which damage to the device may occur

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IGBT characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}, I_C = 10 \text{ mA}, T_{vj} = 25 \text{ }^\circ\text{C}$	1200			V
Collector-emitter ²⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 300 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	1.9	2.3	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$	2.1		V
Collector cut-off current	I_{CES}	$V_{CE} = 1200 \text{ V}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		1	mA
			$T_{vj} = 125 \text{ }^\circ\text{C}$	15		mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}, T_{vj} = 125 \text{ }^\circ\text{C}$	-500		500	nA
Gate-emitter threshold voltage	$V_{GE(TO)}$	$I_C = 12 \text{ mA}, V_{CE} = V_{GE}, T_{vj} = 25 \text{ }^\circ\text{C}$	4.5		6.5	V
Gate charge	Q_{ge}	$I_C = 300 \text{ A}, V_{CE} = 600 \text{ V},$ $V_{GE} = -15 \text{ V} .. 15 \text{ V}$		4000		nC
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz},$ $T_{vj} = 25 \text{ }^\circ\text{C}$		27		nF
Output capacitance	C_{oes}			3.0		
Reverse transfer capacitance	C_{res}			1.3		
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 600 \text{ V},$ $I_C = 300 \text{ A},$ $R_G = 3.3 \text{ } \Omega,$	$T_{vj} = 25 \text{ }^\circ\text{C}$	150		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	180		
Rise time	t_r	$V_{GE} = \pm 15 \text{ V},$ $L_\sigma = 55 \text{ nH},$ inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	80		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	80		
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 600 \text{ V},$ $I_C = 300 \text{ A},$ $R_G = 3.3 \text{ } \Omega,$	$T_{vj} = 25 \text{ }^\circ\text{C}$	770		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	750		
Fall time	t_f	$V_{GE} = \pm 15 \text{ V},$ $L_\sigma = 55 \text{ nH},$ inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	60		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	70		
Turn-on switching energy	E_{on}	$V_{CC} = 600 \text{ V}, I_C = 300 \text{ A},$ $V_{GE} = \pm 15, R_G = 3.3 \text{ } \Omega,$ $L_\sigma = 55 \text{ nH},$ inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	19		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	28		
Turn-off switching energy	E_{off}	$V_{CC} = 600 \text{ V}, I_C = 300 \text{ A},$ $V_{GE} = \pm 15, R_G = 3.3 \text{ } \Omega,$ $L_\sigma = 55 \text{ nH},$ inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	24		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	34		
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ } \mu\text{s}, V_{GE} = 15 \text{ V}, T_{vj} = 125 \text{ }^\circ\text{C},$ $V_{CC} = 900 \text{ V}, V_{CEM \text{ CHIP}} \leq 1200 \text{ V}$		1650		A
Module stray inductance plus to minus	$L_{\sigma \text{ DC}}$			20		nH
Resistance, terminal-chip	$R_{CC'+EE'}$		$T_h = 25 \text{ }^\circ\text{C}$	0.9		m Ω
			$T_h = 125 \text{ }^\circ\text{C}$	1.0		

2) Collector emitter saturation voltage is given at chip level

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Diode characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Continuous forward voltage ³⁾	V_F	$I_F = 300 \text{ A}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	1.9	2.1	V
			$T_{vj} = 125 \text{ }^\circ\text{C}$	1.9		
Peak reverse recovery current	I_{RM}		$T_{vj} = 25 \text{ }^\circ\text{C}$	250		A
			$T_{vj} = 125 \text{ }^\circ\text{C}$	340		
Recovered charge	Q_{RR}	$V_{CC} = 600 \text{ V}$, $I_F = 300 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$,	$T_{vj} = 25 \text{ }^\circ\text{C}$	27		μC
			$T_{vj} = 125 \text{ }^\circ\text{C}$	58		
Reverse recovery time	t_{rr}	$R_G = 3.3 \text{ } \Omega$ $L_\sigma = 55 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	120		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	180		
Reverse recovery energy	E_{rec}		$T_{vj} = 25 \text{ }^\circ\text{C}$	13		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	27		

3) Forward voltage is given at chip level

Thermal properties

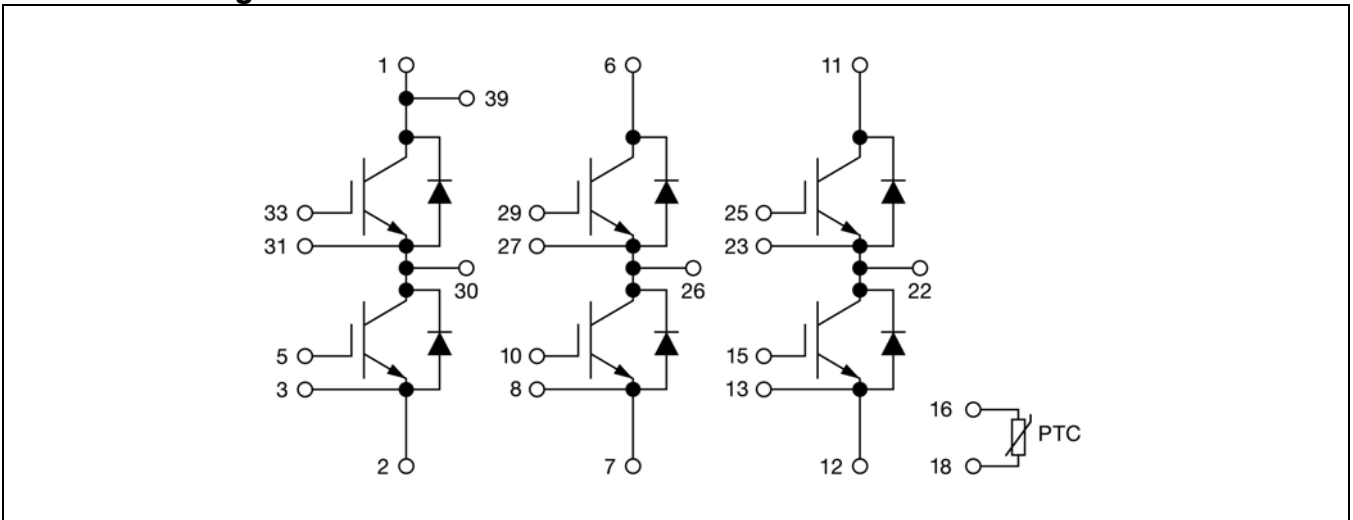
Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance ⁴⁾ junction to heatsink	$R_{th(j-h)IGBT}$	Heatsink: flatness $< \pm 50 \text{ } \mu\text{m}$, roughness $< 6 \text{ } \mu\text{m}$ without ridge			0.13	K/W
Diode thermal resistance ⁴⁾ junction to heatsink	$R_{th(j-h)DIODE}$	Thermal grease: conductivity $\geq 0.8 \text{ W/mK}$, thickness $30 \text{ } \mu\text{m} < t < 50 \text{ } \mu\text{m}$			0.19	K/W
Temperature sensor	PTC	$R_T = R_{T0} \exp [B (1/T - 1/T_0)]$ $R_{T0} = 1\text{k}\Omega (\pm 3\%)$, $B = -760 \text{ K} (\pm 2\%)$, $T_0 = 298 \text{ K}$				

Mechanical properties

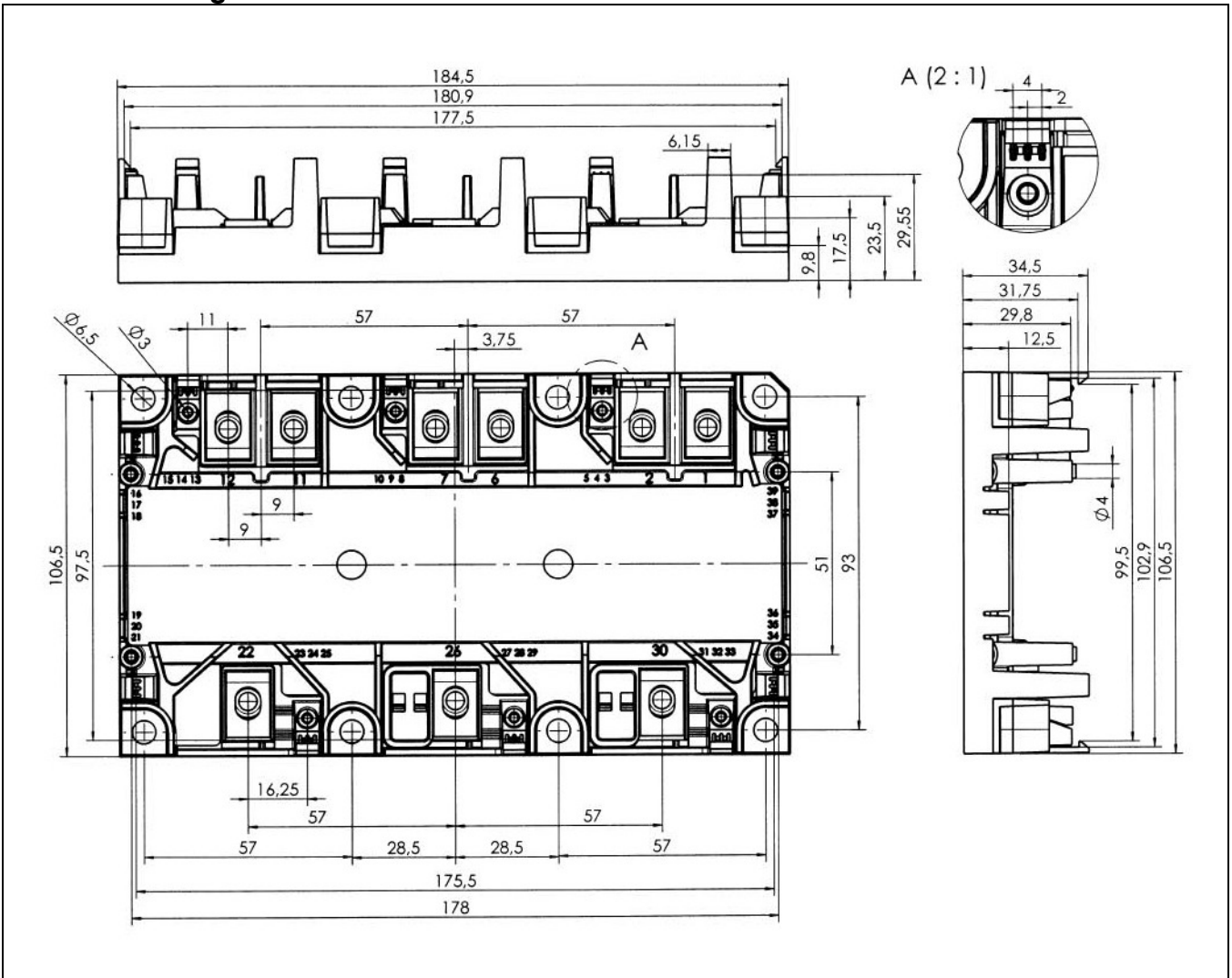
Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	$L \times W \times H$	Typical , see outline drawing	184.5 × 106.5 × 34.5			mm
Clearance distance	D_C	according to IEC 60664-1 and EN 50124-1	Term. to base:	9.5		mm
			Term. to term:	11		
Surface creepage distance	D_{SC}	according to IEC 60664-1 and EN 50124-1	Term. to base:	9.5		mm
			Term. to term:	12.5		
Weight				460		gr
Mounting ⁴⁾	PCB mounting	Hole for selftapping screw: 2.5 mm diameter, 6.0 mm deep				
	Control terminal	Spring pins, pitch of pins = 4 mm, PCB thickness = 1.6 mm				

4) For detailed mounting instructions refer to ABB Document No. 5SYA 2017

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Electrical configuration



Outline drawing



For mounting instructions refer to ABB document No. 5SYA 2017

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.

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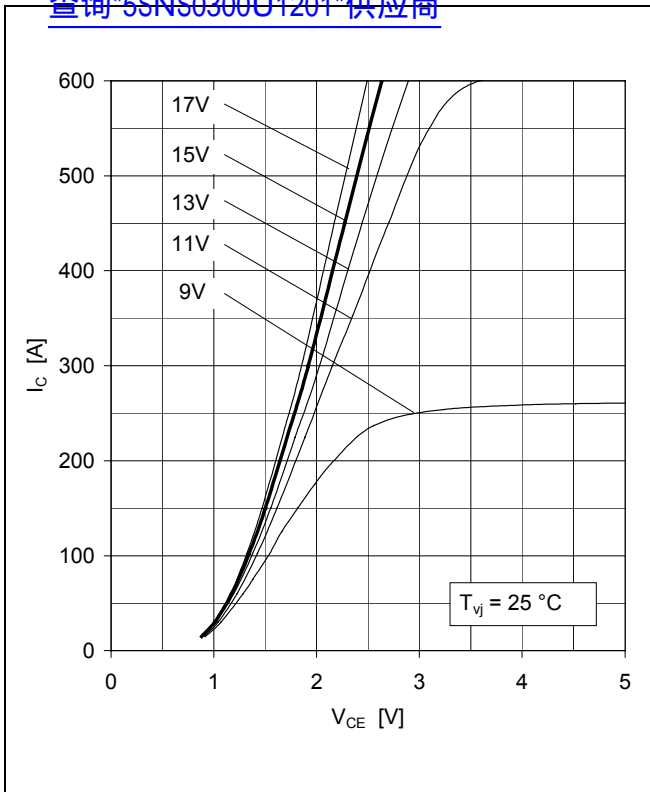


Fig. 1 Typical output characteristics, chip level

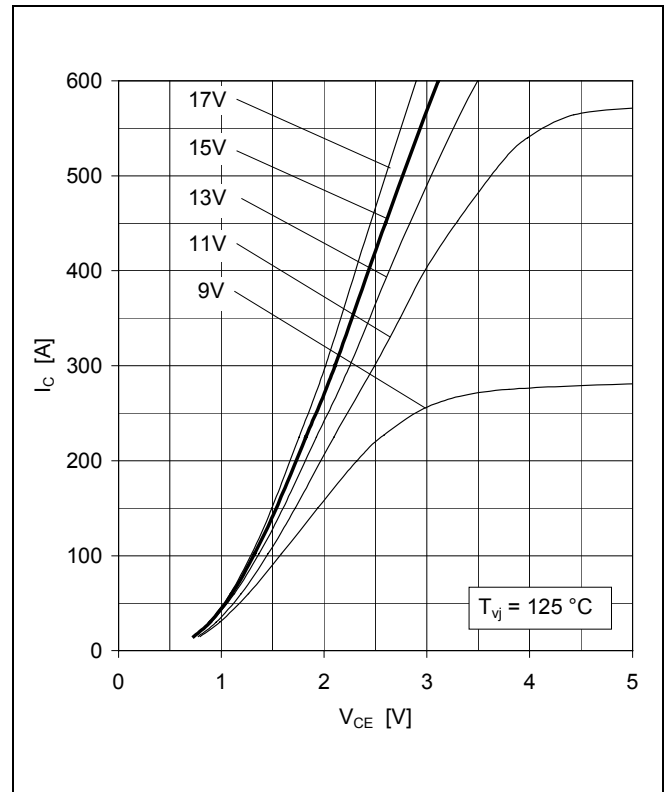


Fig. 2 Typical output characteristics, chip level

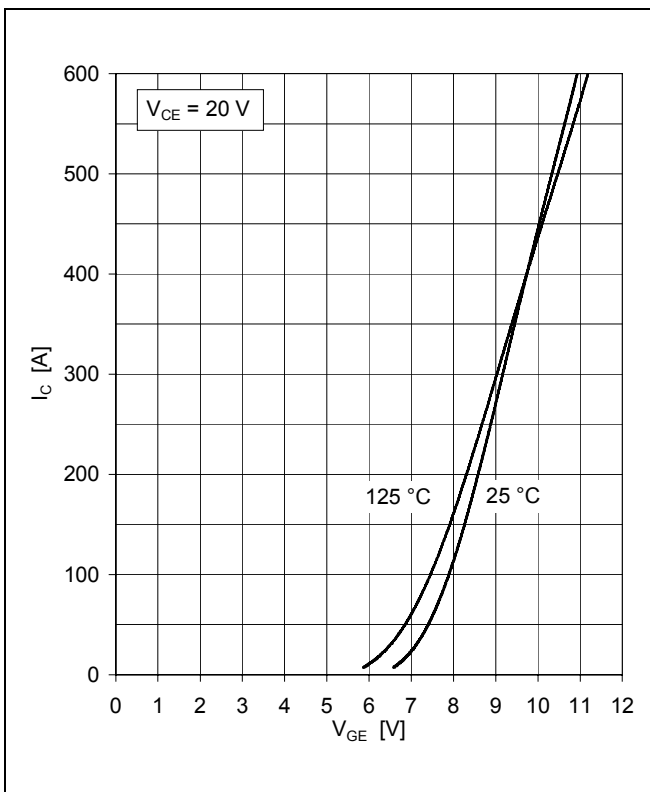


Fig. 3 Typical transfer characteristics, chip level

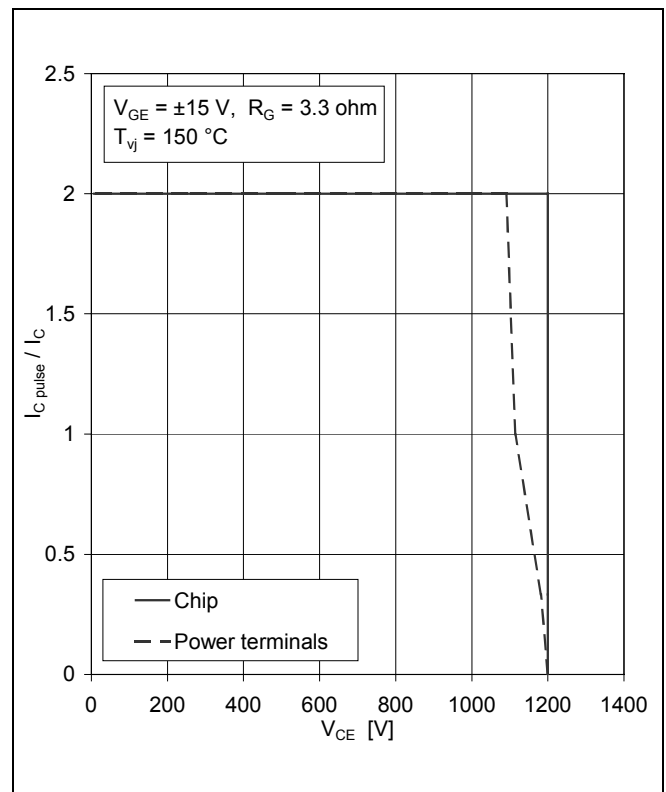


Fig. 4 Turn-off safe operating area (RBSOA)

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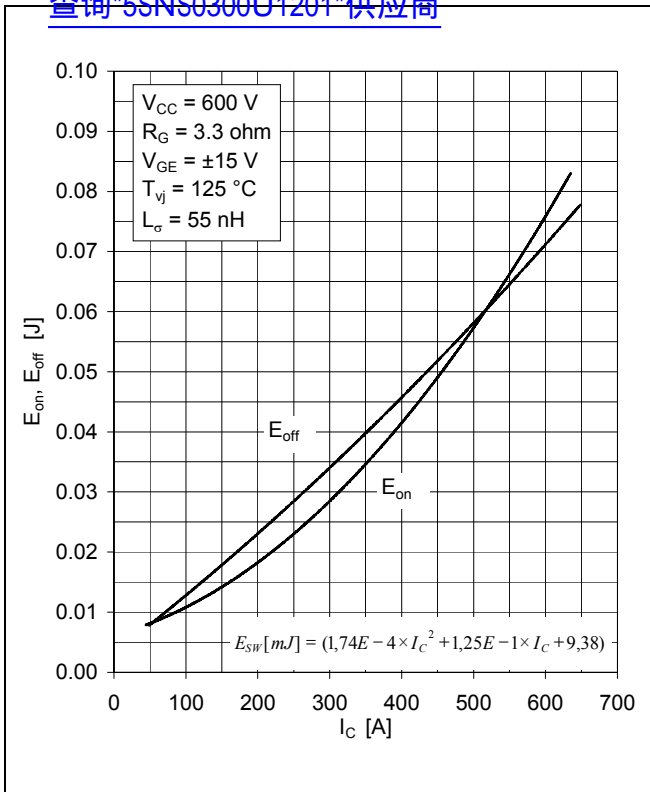


Fig. 5 Typical switching energies per pulse vs collector current

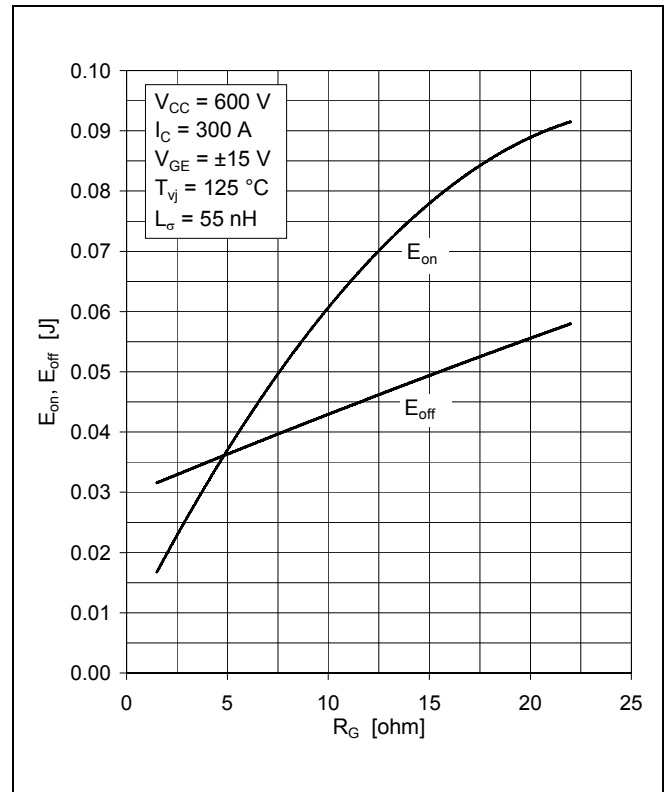


Fig. 6 Typical switching energies per pulse vs gate resistor

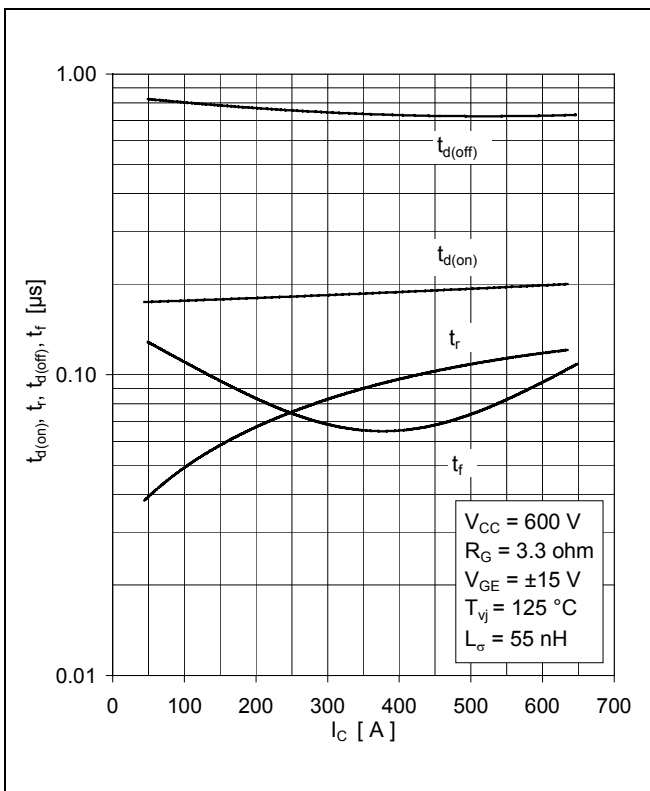


Fig. 7 Typical switching times vs collector current

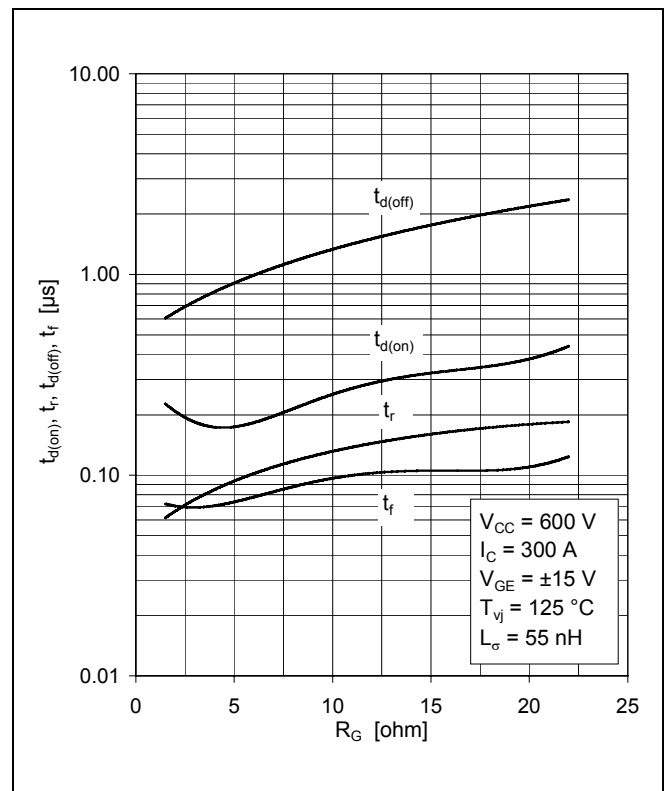


Fig. 8 Typical switching times vs gate resistor

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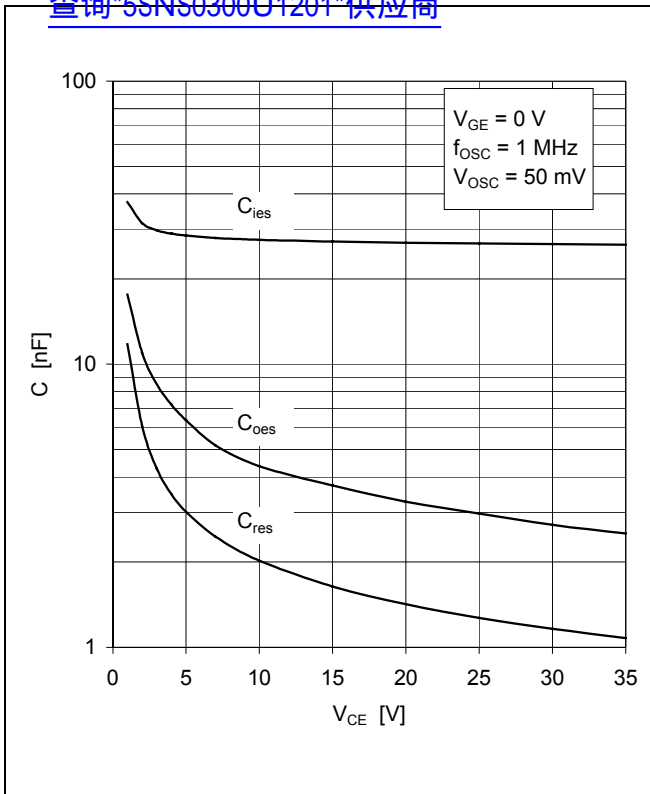


Fig. 9 Typical capacitances vs collector-emitter voltage

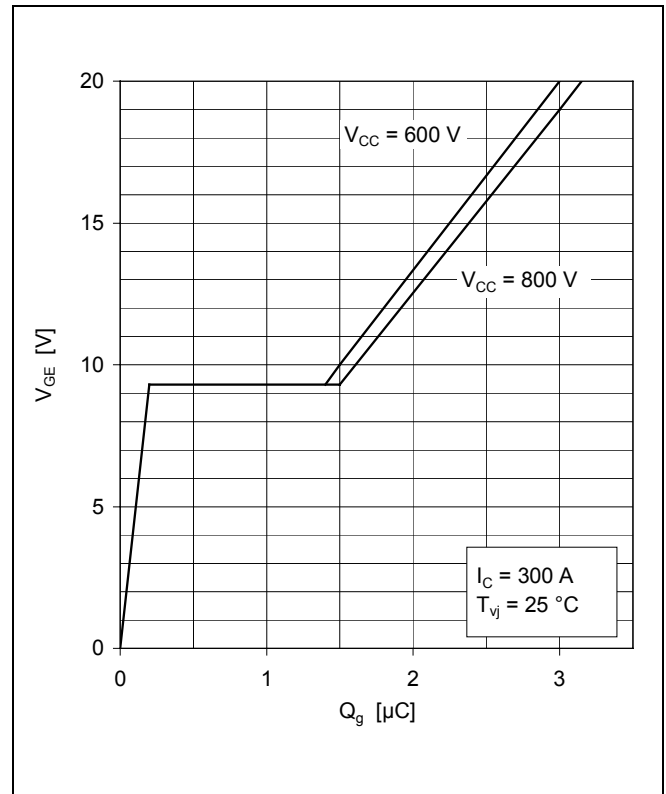


Fig. 10 Typical gate charge characteristics

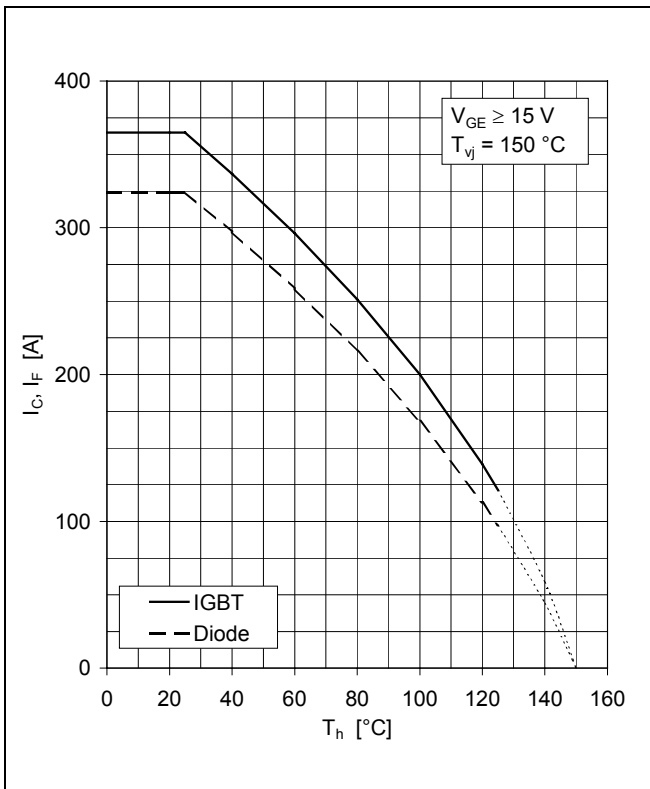


Fig. 11 Rated current vs temperature

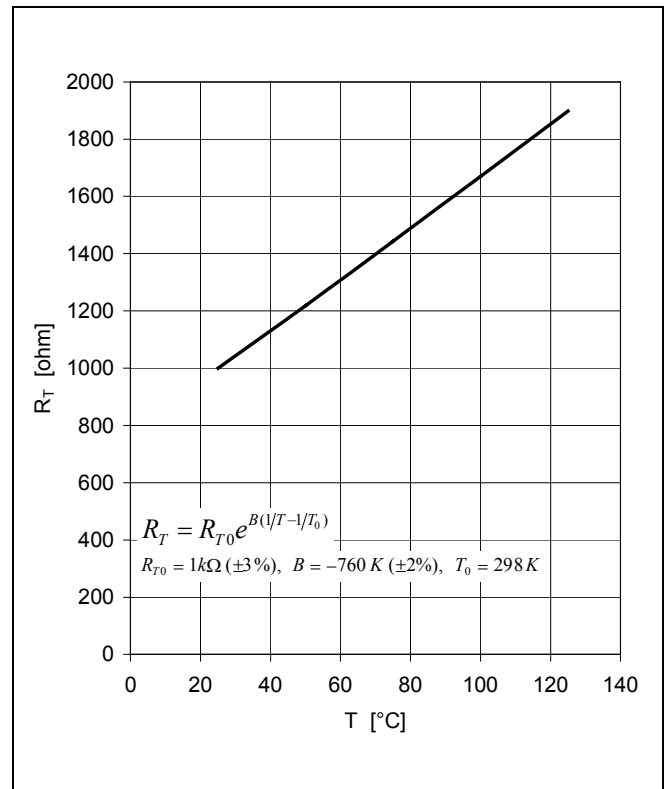


Fig. 12 PTC temperature sensor

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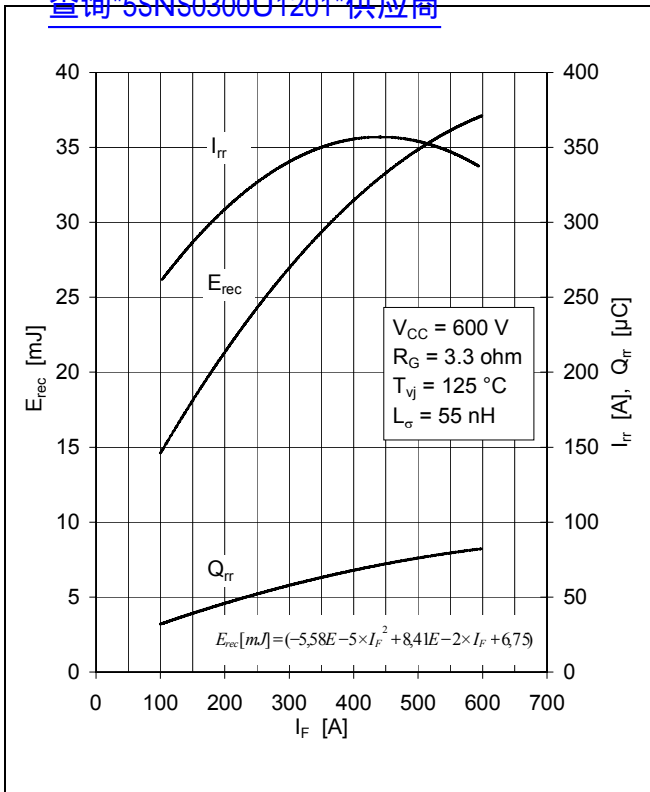


Fig. 13 Typical reverse recovery characteristics vs forward current

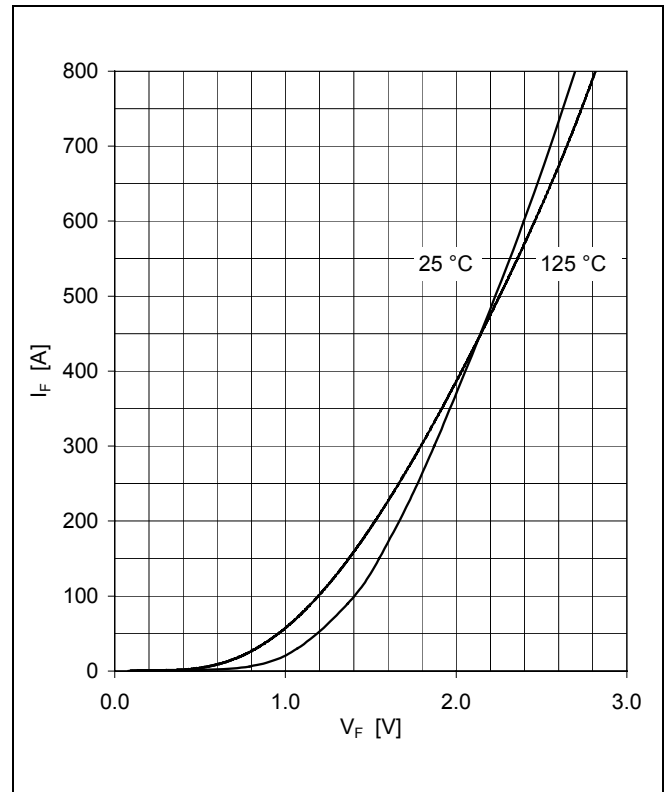


Fig. 14 Typical diode forward characteristics, chip level

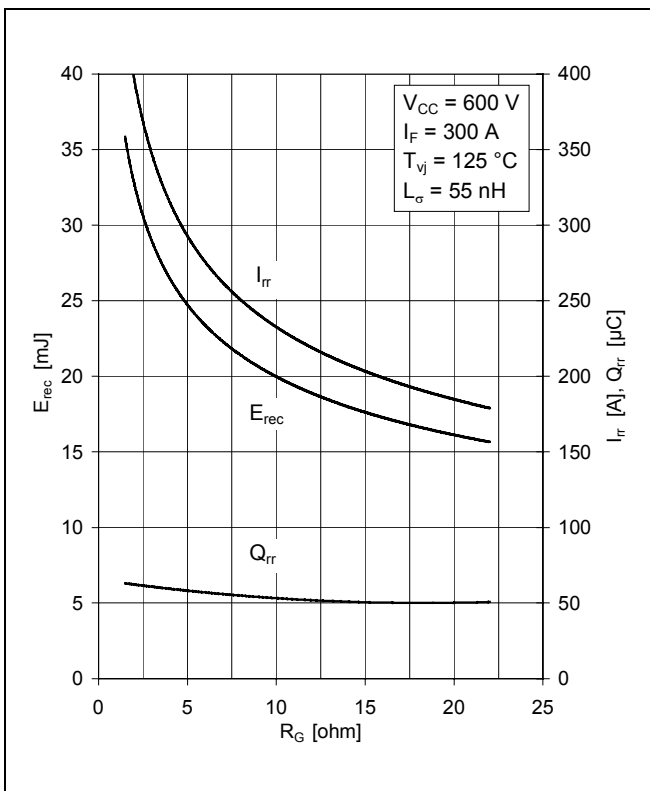


Fig. 15 Typical reverse recovery characteristics vs gate resistor

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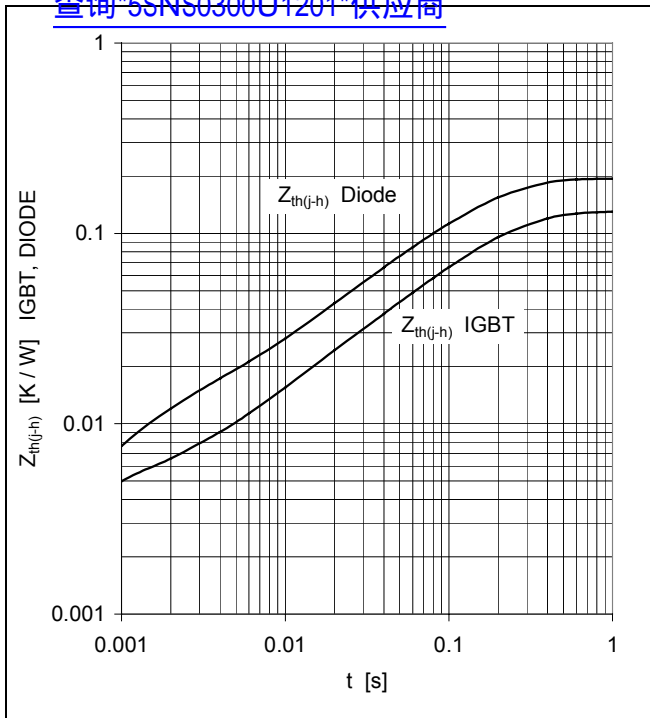


Fig. 16 Typical thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th\ JH}(t) = \sum_{i=1}^n R_i(1 - e^{-t/\tau_i})$$

	i	1	2	3	4	5
IGBT	Ri(K/kW)	117	9	2.4	1.6	
	τ_i (ms)	164	14	0.5	0.2	
DIODE	Ri(K/kW)	167	17	10		
	τ_i (ms)	139	21	1.2		

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ABB

ABB Switzerland Ltd
Semiconductors
 Fabrikstrasse 3
 CH-5600 Lenzburg, Switzerland

Telephone +41 (0)58 586 1419
 Fax +41 (0)58 586 1306
 Email abbsem@ch.abb.com
 Internet www.abb.com/semiconductors